Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	r
10/604,700	OLECHNOWICZ ET AL.	
Examiner	Art Unit	
David E. Bochna	3679	

David E. Bochna

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
Updated the previous search	1/4/2006	DB